

600V N-Channel MOSFET

TO-220

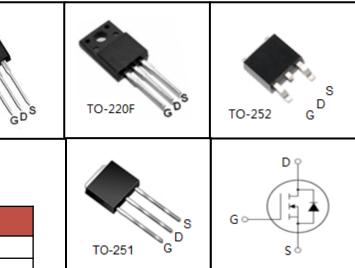
FEATURES

- Fast switching
- 100% avalanche tested
- Improved dv/dt capability

APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)

| Device Marking and Package Information | | | | | |
|--|-----------|-----------|--|--|--|
| Device | Package | Marking | | | |
| CS8N60F | TO-220F | CS8N60F | | | |
| CS8N60P | TO-220 | CS8N60P | | | |
| CS8N60U | TO-251 | CS8N60U | | | |
| CS8N60D | TO-252 | CS8N60D | | | |
| CS8N60F-B | ТО-220F-В | CS8N60F-B | | | |



| Deventer | | 0h.al | Value | | | | |
|--|---------|-----------------------------------|----------|--------|--------|--------|------|
| Parameter | | Symbol | TO-220F | TO-220 | TO-251 | TO-252 | Unit |
| Drain-Source Voltage (V _{GS} = 0V) | | V _{DSS} | 600 | | | V | |
| Continuous Drain Current | | I _D | 8 | | | А | |
| Pulsed Drain Current | (note1) | I _{DM} | 32 | | | | А |
| Gate-Source Voltage | | V _{GSS} | ±30 | | | V | |
| Single Pulse Avalanche Energy | (note2) | E _{AS} | 217.8 | | | mJ | |
| Avalanche Current | (note1) | I _{AR} | 6.6 | | | А | |
| Repetitive Avalanche Energy | (note1) | E _{AR} | 130.6 | | | mJ | |
| Power Dissipation (T _C = 25ºC) | | P _D | 65 106 | | | W | |
| Operating Junction and Storage Temperature Range | | T _J , T _{stg} | -55~+150 | | | | °C |

| Thermal Resistance | | | | | | |
|---|-------------------|---------|--------|--------|--------|---------|
| Parameter | Symbol | Value | | | | l lucit |
| | | TO-220F | TO-220 | TO-251 | TO-252 | Unit |
| Thermal Resistance, Junction-to-Case | R _{thJC} | 1.95 | | 1.17 | | 00.00 |
| Thermal Resistance, Junction-to-Ambient | R _{thJA} | 62.5 | | 60 | •C/W | |

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| D (| | | Value | | | |
|------------------------------------|----------------------|---|-------|-----------|------|------|
| Parameter | Symbol | Test Conditions | Min. | Typ. Max. | | Unit |
| Static | | | | | | |
| Drain-Source Breakdown Voltage | V _{(BR)DSS} | $V_{GS} = 0V, I_{D} = 250 \mu A$ | 600 | | | V |
| Zero Gate Voltage Drain Current | I _{DSS} | $V_{DS} = 600V, V_{GS} = 0V, T_{J} = 25^{\circ}C$ | | | 1 | μA |
| Gate-Source Leakage | I _{GSS} | V_{GS} = $\pm 30V$ | | | ±100 | nA |
| Gate-Source Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}, I_D = 250 \mu A$ | 3.0 | | 4.0 | V |
| Drain-Source On-Resistance (Note3) | $R_{DS(on)}$ | $V_{GS} = 10V, I_D = 4A$ | | 0.85 | 1 | Ω |
| Dynamic | | | | | | |
| Input Capacitance | C _{iss} | | | 966 | | pF |
| Output Capacitance | C _{oss} | $V_{GS} = 0V,$ $V_{DS} = 25V,$ | | 115.5 | | |
| Reverse Transfer Capacitance | C _{rss} | f = 1.0MHz | | 19.5 | | |
| Total Gate Charge | Q _g | | | 35 | | nC |
| Gate-Source Charge | Q _{gs} | $V_{DD} = 480V, I_D = 8A,$ $V_{GS} = 10V$ | | 4.5 | | |
| Gate-Drain Charge | Q_{gd} | | | 18.5 | | |
| Turn-on Delay Time | t _{d(on)} | | | 38.5 | | ns |
| Turn-on Rise Time | t _r | V _{DD} = 300V, I _D =8A, | | 28.5 | | |
| Turn-off Delay Time | t _{d(off)} | $R_{\rm G} = 25 \ \Omega$ | | 153 | | |
| Turn-off Fall Time | t _f | | | 43.6 | | |
| Drain-Source Body Diode Character | istics | | | | | |
| Continuous Body Diode Current | ۱ _s | T 05.00 | | | 8 | A |
| Pulsed Diode Forward Current | I _{SM} | T _C = 25 °C | | | 32 | |
| Body Diode Voltage | V _{SD} | $T_{J} = 25^{\circ}C, I_{SD} = 4A, V_{GS} = 0V$ | | | 1.4 | V |
| Reverse Recovery Time | t _{rr} | V _{GS} = 0V,I _S = 8A, | | 575.6 | | ns |
| Reverse Recovery Charge | Q _{rr} | di _F /dt =100A /µs | | 1.96 | | μC |

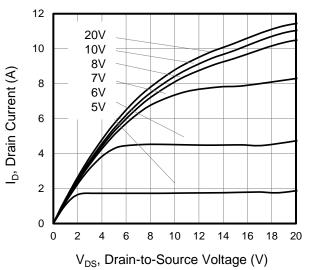
Notes

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L=10mH, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25 °C
- 3. Pulse Test: Pulse width \leq 300µs, Duty Cycle \leq 1%

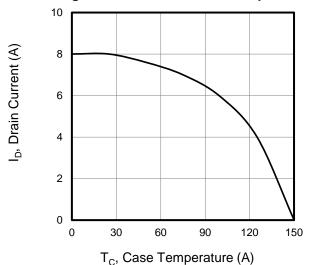


Typical Characteristics $T_J = 25^{\circ}C$, unless otherwise noted

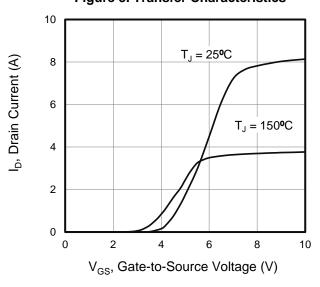
Figure 1. Output Characteristics (T_J = 25°C)











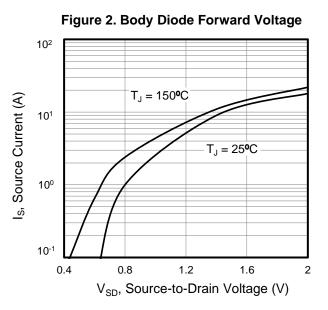


Figure 4. BV_{DSS} Variation vs. Temperature

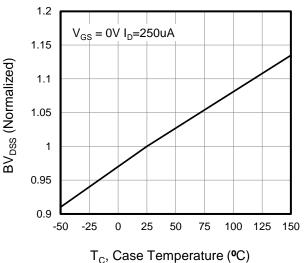
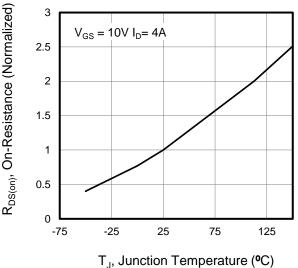
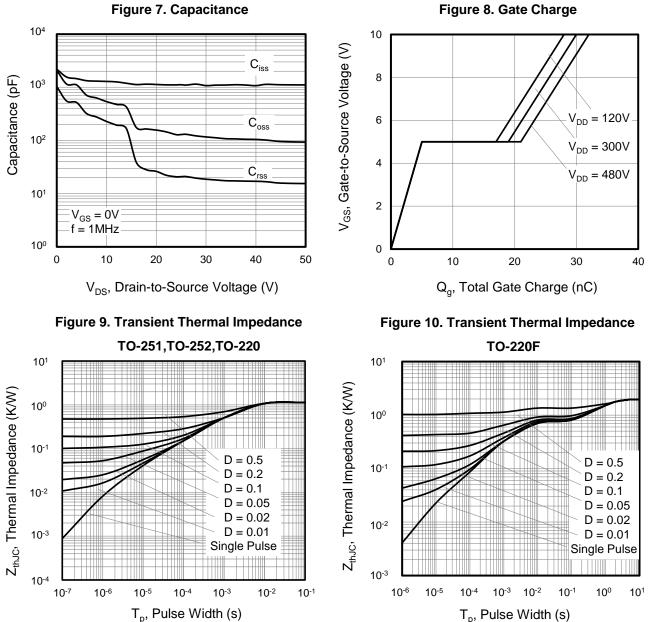


Figure 6. On-Resistance vs. Temperature





Typical Characteristics $T_J = 25^{\circ}C$, unless otherwise noted



T_p, Pulse Width (s)



Figure A: Gate Charge Test Circuit and Waveform

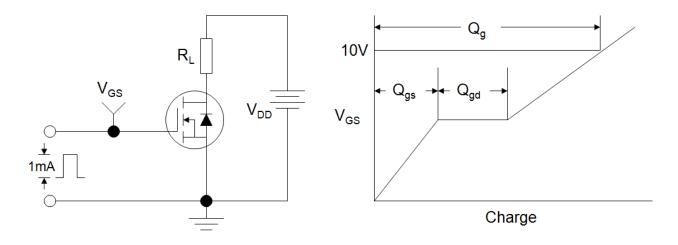


Figure B: Resistive Switching Test Circuit and Waveform

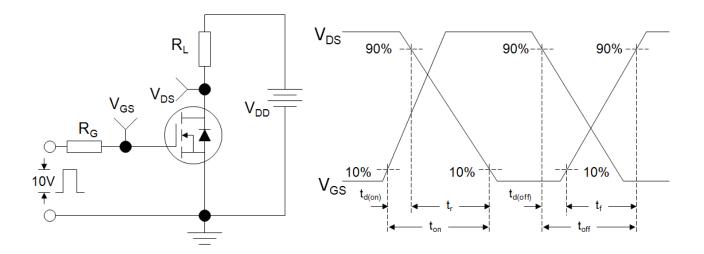
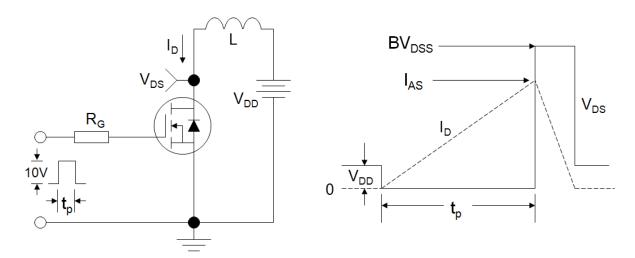
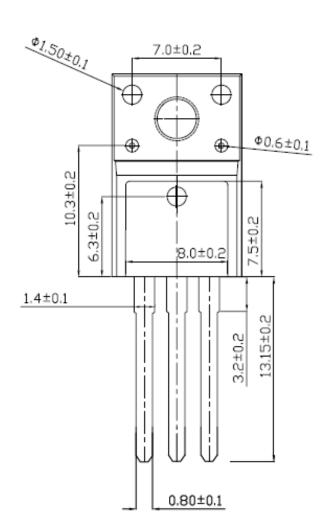


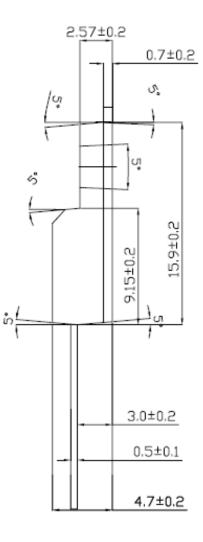
Figure C: Unclamped Inductive Switching Test Circuit and Waveform





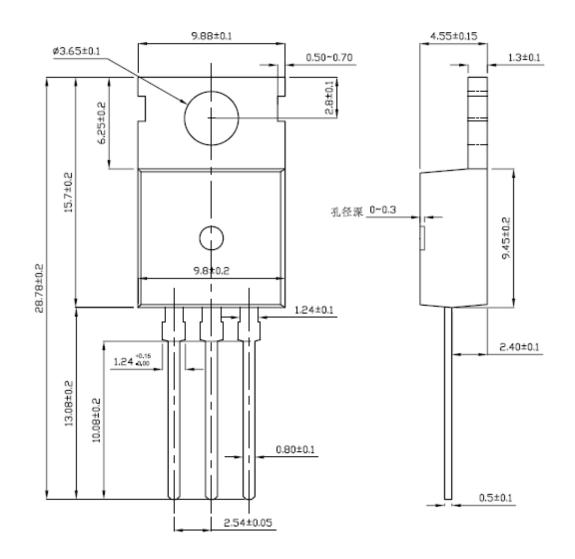
TO-220F





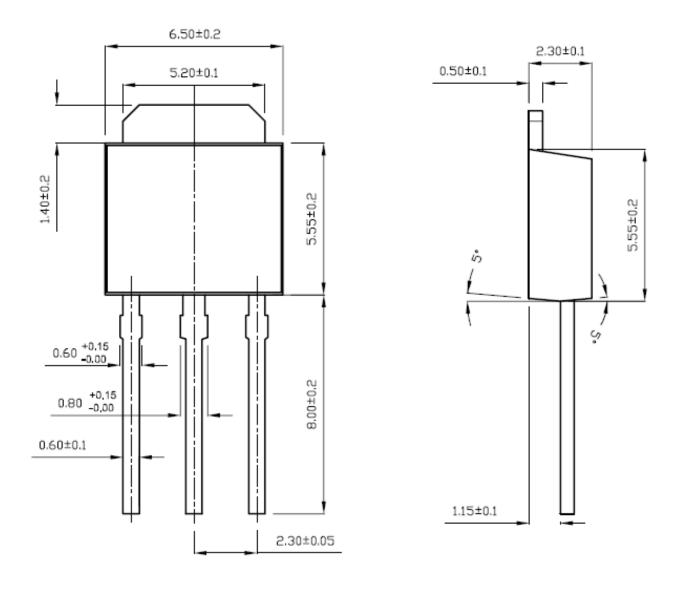


TO-220



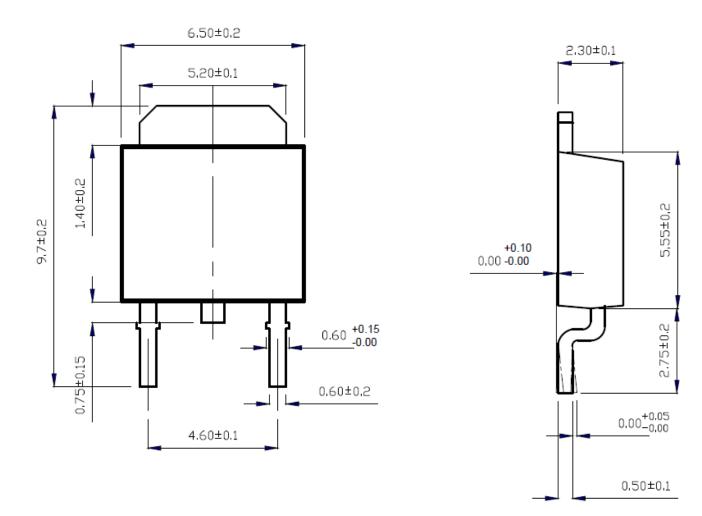


TO-251





TO-252



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